

Search Notes

Application/Control No.

10/636,103

Examiner

Jim Vannucci

Applicant(s)/Patent under
Reexamination

LEE ET AL.

Art Unit

2828

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
same as above		9/23/2005	JV

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
active layer, cladding, etch, phase shift, 372/50	9/23/2005	JV